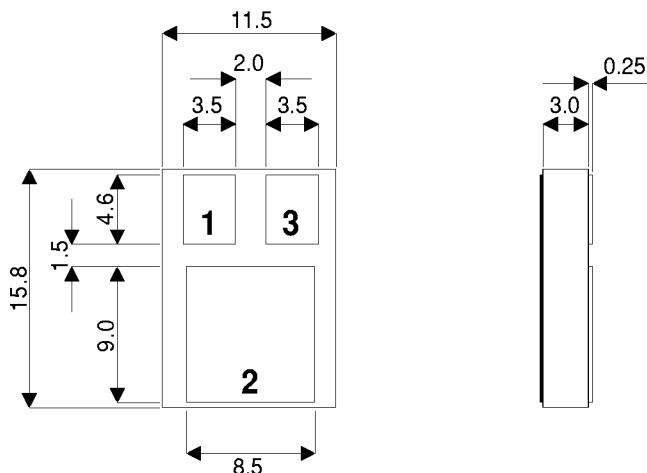


MECHANICAL DATA

Dimensions in mm (inches)


TO-220SM – Surface Mount Package

Pad 1 – Source

Pad 2 – Drain

Pad 3 – Gate

Note: IRFxxxSM also available with pins 1 and 3 reversed.

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^\circ\text{C}$ unless otherwise stated)

V_{GS}	Gate – Source Voltage	$\pm 20\text{V}$
I_D	Continuous Drain Current ($V_{GS} = 0$, $T_{case} = 25^\circ\text{C}$)	22A
I_D	Continuous Drain Current ($V_{GS} = 0$, $T_{case} = 100^\circ\text{C}$)	13.9A
I_{DM}	Pulsed Drain Current ¹	88A
P_D	Power Dissipation @ $T_{case} = 25^\circ\text{C}$	75W
	Linear Derating Factor	0.6W/ $^\circ\text{C}$
E_{AS}	Single Pulse Avalanche Energy ²	250mJ
dv/dt	Peak Diode Recovery ³	5.5V/ns
T_J , T_{stg}	Operating and Storage Temperature Range	-55 to 150 $^\circ\text{C}$
T_L	Package Mounting Surface Temperature (for 5 sec)	300 $^\circ\text{C}$
$R_{\theta JC}$	Thermal Resistance Junction to Case	1.67 $^\circ\text{C}/\text{W}$
$R_{\theta J-PCB}$	Thermal Resistance Junction to PCB (Typical)	4 $^\circ\text{C}/\text{W}$

Notes

1) Pulse Test: Pulse Width $\leq 300\text{ms}$, $\delta \leq 2\%$

2) @ $V_{DD} = 25\text{V}$, $L \geq 0.8\text{mH}$, $R_G = 25\Omega$, Peak $I_L = 22\text{A}$, Starting $T_J = 25^\circ\text{C}$

3) @ $I_{SD} \leq 22\text{A}$, $di/dt \leq 170\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, $T_J \leq 150^\circ\text{C}$, SUGGESTED $R_G = 9.1\Omega$

ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^\circ C$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
STATIC ELECTRICAL RATINGS					
BV_{DSS}	Drain – Source Breakdown Voltage	$V_{GS} = 0$	$I_D = 1mA$	100	V
ΔBV_{DSS}	Temperature Coefficient of Breakdown Voltage	Reference to $25^\circ C$		0.13	$V/^\circ C$
$R_{DS(on)}$	Static Drain – Source On-State Resistance ¹	$V_{GS} = 10V$	$I_D = 13.9A$	0.077	Ω
		$V_{GS} = 10V$	$I_D = 22A$	0.125	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$	$I_D = 250\mu A$	2	V
g_{fs}	Forward Transconductance ¹	$V_{DS} \geq 15V$	$I_{DS} = 13.9A$	9.1	$S(\Omega)$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0$	$V_{DS} = 0.8BV_{DSS}$	25	μA
			$T_J = 125^\circ C$	250	
I_{GSS}	Forward Gate – Source Leakage	$V_{GS} = 20V$		100	nA
$ I_{GSS} $	Reverse Gate – Source Leakage	$V_{GS} = -20V$		-100	
DYNAMIC CHARACTERISTICS					
C_{iss}	Input Capacitance	$V_{GS} = 0$		1660	pF
C_{oss}	Output Capacitance	$V_{DS} = 25V$		550	
C_{rss}	Reverse Transfer Capacitance	$f = 1MHz$		120	
Q_g	Total Gate Charge ¹	$V_{GS} = 10V$	$I_D = 22A$	30	nC
		$V_{DS} = 0.5BV_{DSS}$		59	
Q_{gs}	Gate – Source Charge ¹	$I_D = 22A$		2.4	nC
Q_{gd}	Gate – Drain ("Miller") Charge ¹	$V_{DS} = 0.5BV_{DSS}$		12	
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 50V$		21	ns
t_r	Rise Time	$I_D = 22A$		145	
$t_{d(off)}$	Turn-Off Delay Time	$R_G = 9.1\Omega$		64	
t_f	Fall Time			105	
SOURCE – DRAIN DIODE CHARACTERISTICS					
I_s	Continuous Source Current			22	A
I_{SM}	Pulse Source Current ²			88	
V_{SD}	Diode Forward Voltage	$I_s = 22A$	$T_J = 25^\circ C$		V
		$V_{GS} = 0$		1.5	
t_{rr}	Reverse Recovery Time	$I_F = 22A$	$T_J = 25^\circ C$	400	ns
Q_{rr}	Reverse Recovery Charge	$d_i / d_t \leq 100A/\mu s$	$V_{DD} \leq 50V$	2.9	μC
t_{on}	Forward Turn-On Time			Negligible	
PACKAGE CHARACTERISTICS					
L_D	Internal Drain Inductance (from centre of drain pad to die)			0.8	nH
L_S	Internal Source Inductance (from centre of source pad to end of source bond wire)			2.8	

Notes

- 1) Pulse Test: Pulse Width $\leq 300ms$, $\delta \leq 2\%$
- 2) Repetitive Rating – Pulse width limited by maximum junction temperature.